

General Description

WSD2067 combines a P-Channel enhancement mode power MOSFET which is produced with high cell density and DMOS trench technology and a low forward voltage schottky diode. the tiny and thin outline saves PCB consumption.

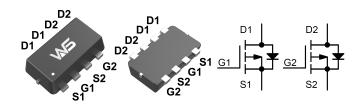
Applications

- Bidirectional blocking switch;
- DC-DC conversion applications;
- Li-battery charging;

Product Summery

| V _{DSS} | R _{DSON} (typ.) | I _D |
|------------------|--------------------------|----------------|
| -20V | 60mΩ@-4.5V | |
| | 75mΩ@-2.5V | -3.5A |
| | 105mΩ@-1.8V | |

DFN3x2_8L_EP Pin Configuration



Absolute Maximum Ratings (T_A = 25 °C Unless Otherwise Noted)

| Symbol | Parameter | Rating | Units | |
|-------------------------------------|---|------------|---------------|--|
| V_{DS} | Drain-Source Voltage | -20 | V | |
| V_{GS} | Gate-Source Voltage | ±8 | V | |
| I _D @T _c =25℃ | Continuous Drain Current, V _{GS} = -4.5V ¹ | -3.5 | Α | |
| I _{DM} | 300µS Pulsed Drain Current, (V _{GS} =-4.5V) | -25 | Α | |
| V_{R} | Schottky Reverse Voltage | 20 | V | |
| I _F | Schottky Continuous Forw ard Current | 2 | Α | |
| P _D | Power Dissipation Derating above T _A = 25°C (Note 2) | 1.2 | W | |
| T_{STG},T_{J} | Storage Temperature Range | -55 to 150 | ${\mathbb C}$ | |
| $R_{\theta JA}$ | Thermal Resistance Junction-ambient ¹ | 80 | °C/W | |
| Rejc | Thermal Resistance Junction-Case ¹ | 50 | °C/W | |

Note1: Devices mounted on FR4 PCB with minima soldering pad;

Note2: For a single chip.

Dual P-Ch MOSFET

Electrical Characteristics (T_J=25 °C, unless otherwise noted)

| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit |
|--------------------------------------|--|--|------|-------|------|------|
| BV _{DSS} | Drain-Source Breakdown Voltage | V _{GS} =0V , I _D =-250uA | -20 | | | V |
| $\triangle BV_{DSS}/\triangle T_{J}$ | BVDSS Temperature Coefficient | Reference to 25 $^{\circ}\mathrm{C}$, I _D =-1mA | | -0.01 | | V/°C |
| R _{DS(ON)} | Static Drain-Source On-Resistance ² | V _{GS} =-4.5V , I _D =-1A | | 60 | 99 | mΩ |
| | | V _{GS} =-2.5V , I _D =-1A | | 75 | 120 | |
| | | V _{GS} =-1.8V , I _D =-1A | | 105 | 180 | |
| V _{GS(th)} | Gate Threshold Voltage | V _{GS} =V _{DS} , I _D =-250uA | -0.5 | -0.7 | -1.2 | V |
| $\triangle V_{GS(th)}$ | V _{GS(th)} Temperature Coefficient | | | 3.13 | | mV/℃ |
| | Drain-Source Leakage Current | V _{DS} =-16V , V _{GS} =0V , T _J =25℃ | | | -1 | uA |
| I _{DSS} | | V _{DS} =-16V , V _{GS} =0V , T _J =55℃ | | | -5 | |
| I _{GSS} | Gate-Source Leakage Current | $V_{GS}=\pm12V$, $V_{DS}=0V$ | | | ±100 | nA |
| gfs | Forward Transconductance | V _{DS} =-5V , I _D =-1A | | 16 | | S |
| R_g | Gate Resistance | V _{DS} =0V , V _{GS} =0V , f=1MHz | | 2 | | Ω |
| Qg | Total Gate Charge (-4.5V) | V _{DS} =-10V , V _{GS} =-4.5V , I _D =-1A | | 5.2 | | nC |
| Q _{gs} | Gate-Source Charge | | | 0.7 | | |
| Q_{gd} | Gate-Drain Charge | | | 1.8 | | |
| T _{d(on)} | Turn-On Delay Time | | | 20 | | ns |
| T _r | Rise Time | V _{DD} =-10V , V _{GS} =-4.5V , | | 18 | | |
| T _{d(off)} | Turn-Off Delay Time | $R_G=6\Omega I_D=-1A,$ | | 300 | | |
| T _f | Fall Time | | | 120 | | |
| C _{iss} | Input Capacitance | V _{DS} =-10V , V _{GS} =0V , f=1MHz | | 420 | | pF |
| C _{oss} | Output Capacitance | | | 180 | | |
| C _{rss} | Reverse Transfer Capacitance | | | 90 | | |

Note:

^{1.} The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper, t \leq 10sec.

^{2.}The data tested by pulsed , pulse width $\,\leq\,$ 300us , duty cycle $\,\leq\,$ 2%

^{3.} The power dissipation is limited by 150 $^{\circ}\mathrm{C}$ junction temperature

^{4.} The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



Typical Performance Characteristics of P-Channel MOSFET

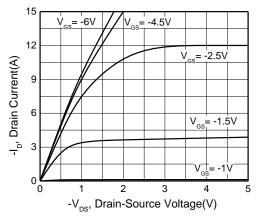


Fig 1. Output Characteristics

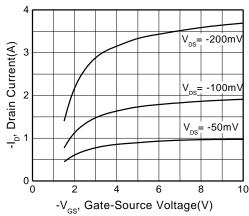


Fig 2. Transfer Characteristics

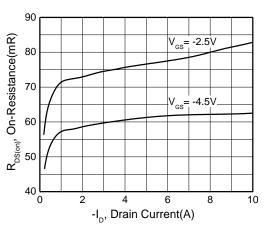


Fig 3. On-Resistance vs. Drain Current

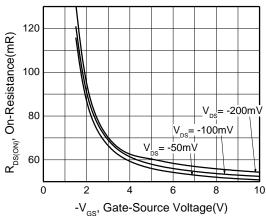


Fig 4. On-Resistance vs.Gate-Source Valtage

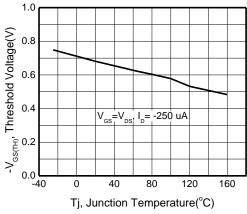


Fig 5. Threshold Voltage

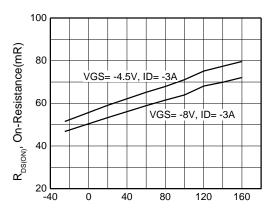
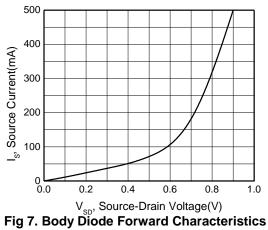
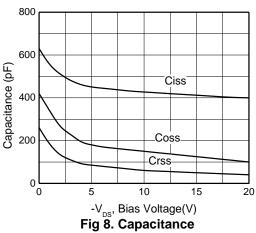


Fig 6. On-Resistance Temperature Coefficient







Typical Performance Characteristics of Schottky

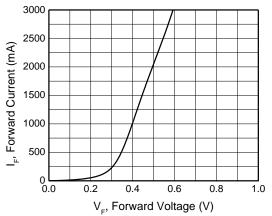


Figure 9. Schottky Forward Characteristics

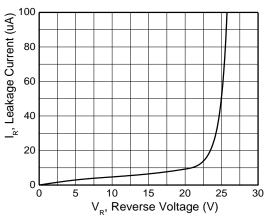


Figure 10. Schottky Reverse Characteristics

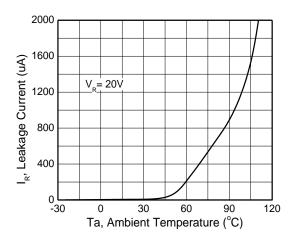
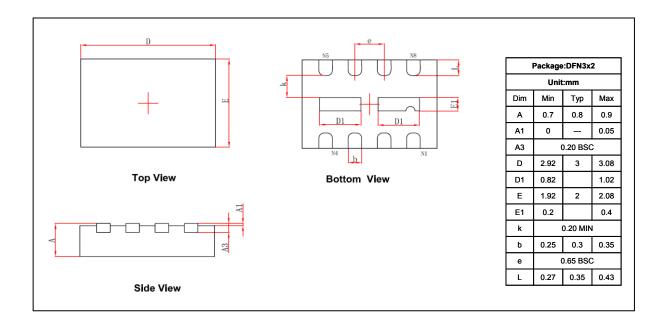


Figure 11. Leakage Current Vs. Temperature



Package Information DFN3x2_8L_EP





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